

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/566,571	SAWAI, MASAYOSHI	
Examiner	Art Unit	
Tung S. Lau	2863	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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